

18A 650V N-channel Enhancement Mode Power MOSFET

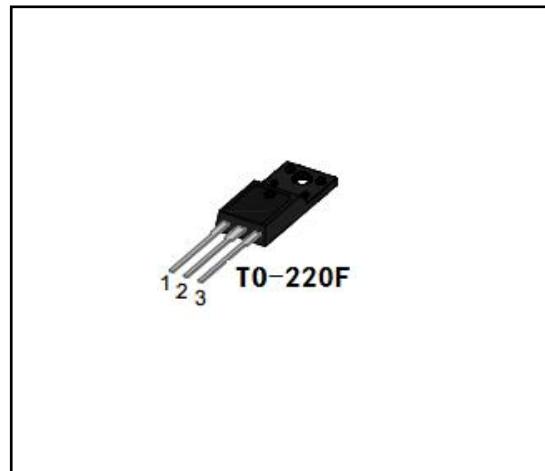
1 Description

These N-channel enhanced vdmosfets, is obtained by the self-aligned planar technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. Which accords with the RoHS standard. TO-220F provides insulation voltage rated at 2000V RMS from all three terminals to external heatsink. TO-220F series comply with UL standards (File ref:E252906).

	$V_{DSS} = 650V$ $I_D = 18.0A$ $R_{DS(on)} \text{ (TYP)} = 0.42\Omega$
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2 Features

- Fast switching
- ESD improved capability
- Low on resistance($R_{DS(on)} \leq 0.55\Omega$)
- Low gate charge(Typ: 58nC)
- Low reverse transfer capacitances(Typ: 20pF)
- 100% single pulse avalanche energy test
- 100% ΔV_{DS} test



3 Applications

- Used in various power switching circuit for system miniaturization and higher efficiency.
- Power switch circuit of electron ballast and adaptor.

4 Electrical Characteristics

4.1 Absolute Maximum Ratings ($T_c=25^\circ C$, unless otherwise noted)

PARAMETER		SYMBOL	VALUE	UNIT
Drain-Source Voltage		V_{DS}	650	V
Gate-Source Voltage		V_{GS}	± 30	V
Drain Current(continuous) ^(Note 3)		I_D	18	A
Drain Current(continuous)($T=100^\circ C$) ^(Note 3)		I_D	11	A
Drain Current(Pulsed)		I_{DM}	72	A
Single Pulse Avalanche Energy ^(Note 4)		E_{AS}	1500	mJ
Derating Factor above $T_a=25^\circ C$		P_D	0.36	W
Power Dissipation $T_c=25^\circ C$			45	W
Operating Junction Temperature Range		T_j	-55~150	°C
Storage Temperature Range		T_{stg}	-55~150	°C
High Temperature(tin solder)		T_L	300	°C

4.2 Thermal Characteristics

PARAMETER		SYMBOL	VALUE	UNIT
Thermal Resistance, Junction to Case-sink		R_{thJC}	2.78	°C/W
Thermal Resistance, Junction to Ambient		R_{thJA}	62.5	°C/W

4.3 Electrical Characteristics (T_c=25°C, unless otherwise noted)

PARAMETER	SYMBOL	Test Condition	VALUE			UNIT
			MIN	TYP	MAX	
Off Characteristics						
Drain-source Breakdown Voltage	BV _{DSS}	I _D =250μA,V _{GS} =0V	650	--	--	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =650V,V _{GS} =0V, T _C =25°C	--	--	1	μA
		V _{DS} =520V,V _{GS} =0V, T _C =125°C	--	--	100	μA
Gate-to-Body Leakage Current	I _{GSS}	V _{GS} =±30V,V _{DS} =0V	--	--	±100	nA
On Characteristics ^(Note 3)						
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	2.0	--	4.0	V
Drain-source on Resistance	R _{DS(on)}	V _{GS} =10V,I _D =9.0A	--	0.42	0.55	Ω
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{GS} =0V,V _{DS} =25V, f=1.0MHz	--	2983	--	pF
Output Capacitance	C _{oss}		--	316	--	
Reverse Transfer Capacitance	C _{rss}		--	20	--	
Turn-on Delay Time	T _{d(on)}	ID=18A, VDD=250V, VGS=10V, RG=10Ω	--	36	--	ns
Turn-on Rise Time	t _r		--	74.7	--	
Turn-off Delay Time	T _{d(off)}		--	78.7	--	
Turn-off Fall	t _f		--	58.7	--	
Total Gate Charge	Q _g	ID=18A, VDD=400V, VGS=10V	--	58	--	nc
Gate-to-Source Charge	Q _{gs}		--	13.3	--	
Gate-to-Drain("Miller")C harge	Q _{gd}		--	22.9	--	
Drain-Source Diode Characteristics						
Diode Forward Voltage ^(Note 3)	V _{FSD}	V _{GS} =0V,I _s =18A	--	--	1.5	V
Continuous Source Current (BodyDiode) ^(Note 3)	I _s		--	--	20	A
Reverse Recovery Time	trr	T _J =25°C ,IF=18A, dI/dt=100A/μS,VGS=0V	--	584	--	ns
Reverse Recovery Charge	Qrr		--	6853	--	nc

Notes:

1: Repetitive rating, pulse width limited by maximum junction temperature.

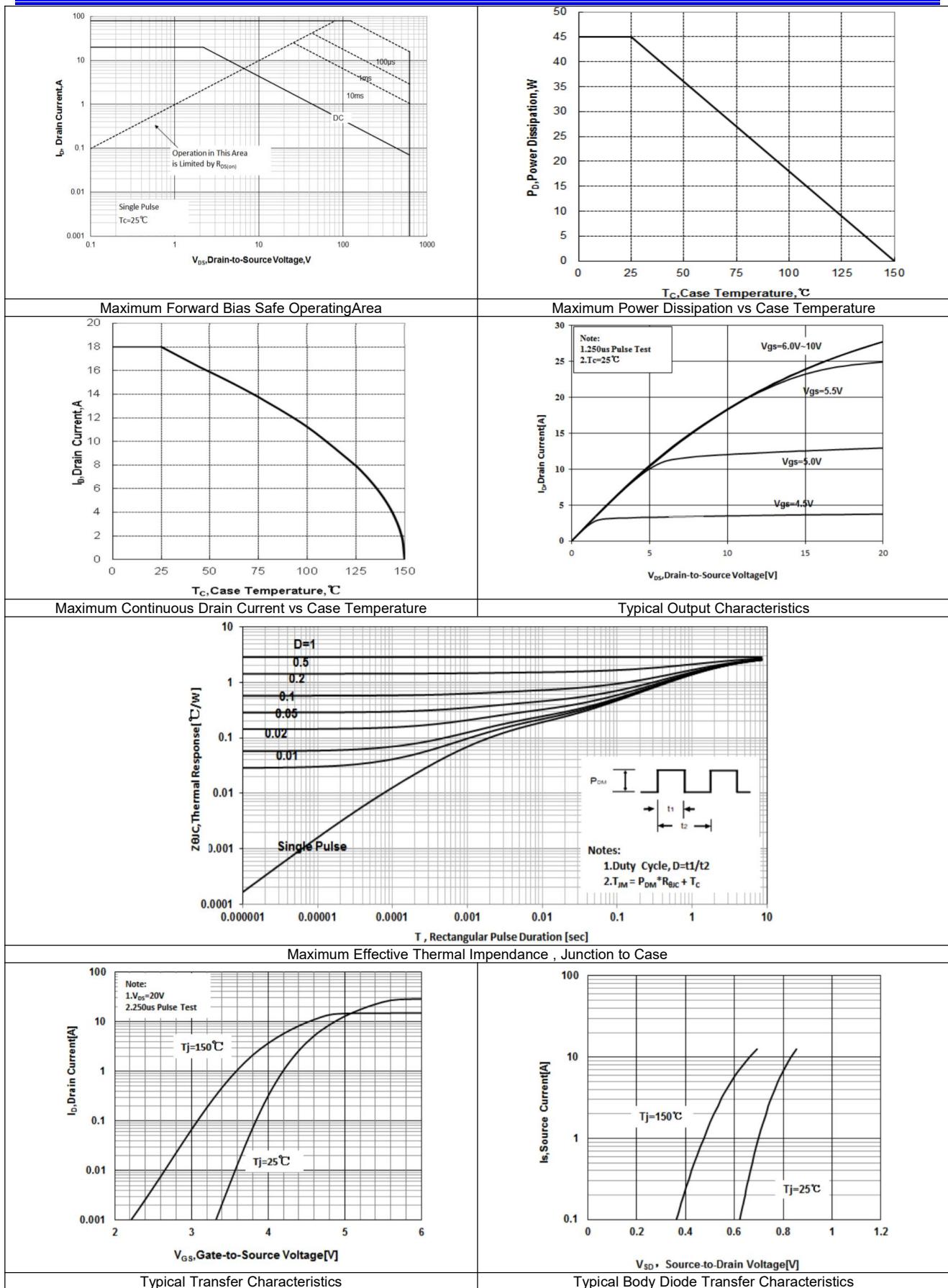
2: Surface mounted on FR4 Board, t≤10sec.

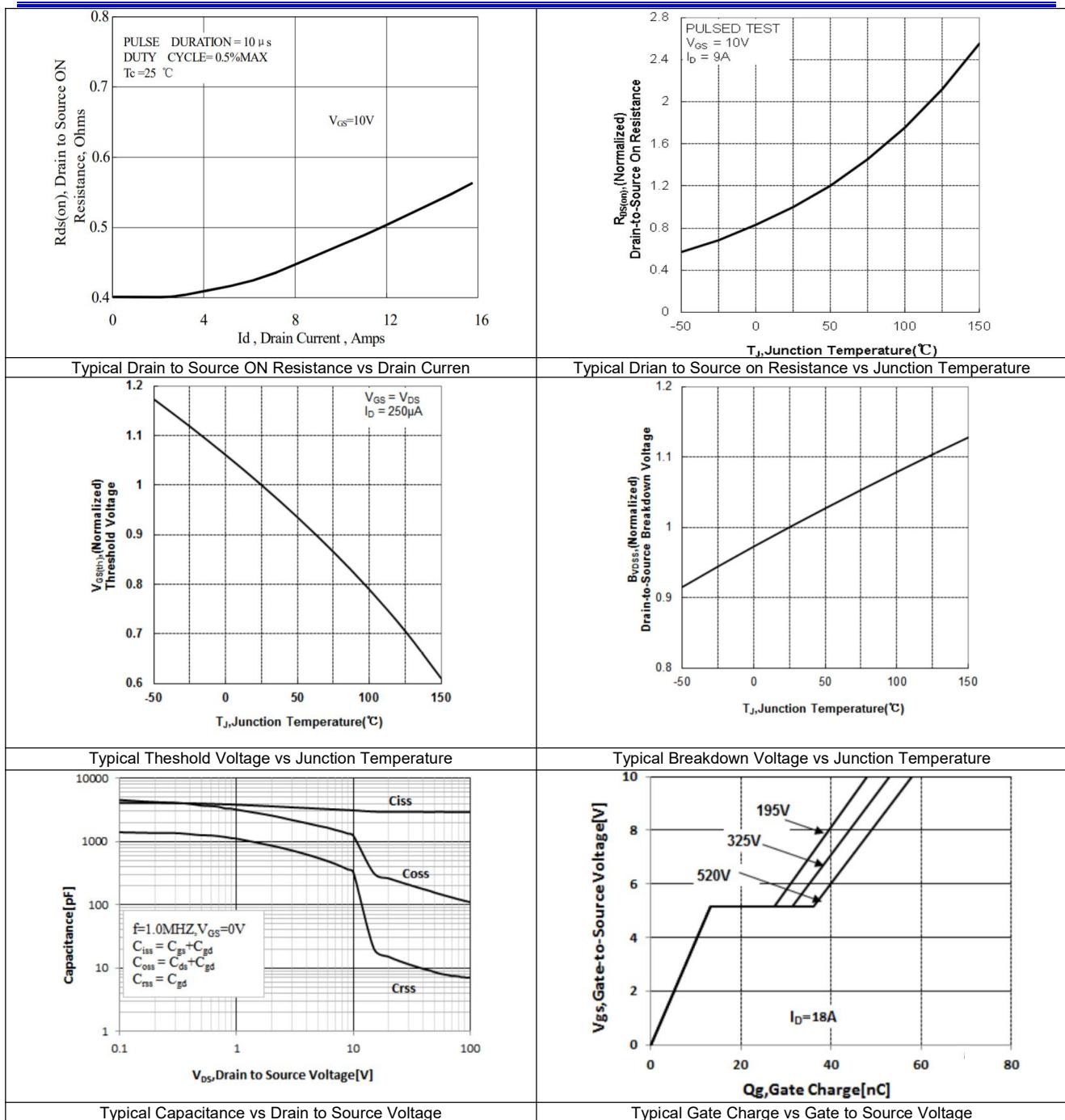
3: Pulse width ≤ 300μs, duty cycle ≤ 2%.

4: L=30mH,I_D=10A,V_{DD}=150V,,Start T_J=25°C.

5 Typical Test Circuit and Waveform

<p>Gate Charge Test Circuit</p>	<p>Gate Charge Waveforms</p>
<p>Resistive Switching Test Circuit</p>	<p>Resistive Switching Waveforms</p>
<p>Diode Reverse Recovery Test Circuit</p>	<p>Diode Reverse Recovery Waveform</p>
<p>Unclamped Inductive Switching Test Circuit</p>	<p>Unclamped Inductive Switching Waveform</p>



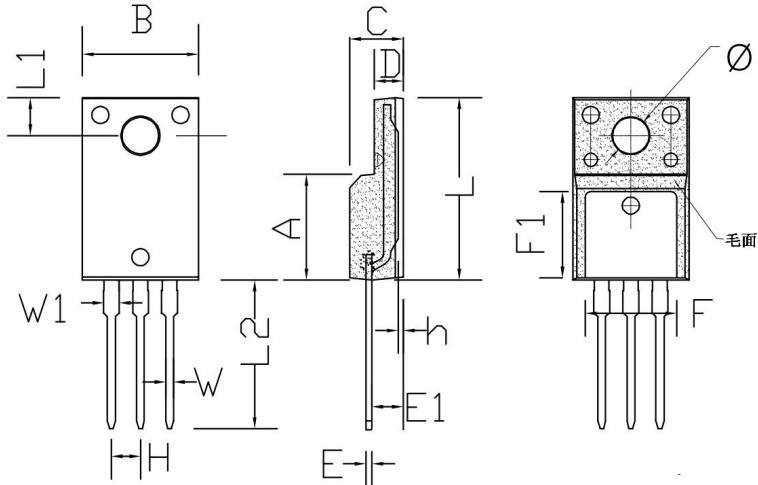


6 Product Specifications and Packaging Models

Product Model	Package Type	Mark Name	RoHS	Package	Quantity
F18N65	TO-220F	F18N65	Pb-free	Tube	1000/box

7 Dimensions

TO-220F PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions in Millimeters		Dimensions in Inches	
	min.	max.	min.	max.
A	8.80	9.30	0.346	0.366
B	10.00	10.50	0.394	0.413
C	4.30	4.90	0.169	0.193
D	2.30	2.70	0.091	0.106
L	15.55	16.15	0.612	0.636
h	0.40	0.60	0.016	0.024
L1	3.15	3.55	0.124	0.140
L2	12.65	13.35	0.498	0.526
W	0.70	0.90	0.028	0.035
W1	1.15	1.55	0.045	0.061
H	2.54 TYP		0.100 TYP	
E	0.48	0.53	0.019	0.021
Φ	2.90	3.40	0.114	0.134
E1	2.40	2.90	0.094	0.114
F	7.75	8.25	0.305	0.325
F1	7.35	7.85	0.289	0.309

8 Atentions

- Jiangsu Donghai Semiconductor Co.,Ltd. reserves the right to change the specification without prior notice! The customer should obtain the latest version of the information before making the order and verify that the information is complete and up to date.
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- Product promotion is endless, our company will be dedicated to provide customers with better products.

9 Appendix

Revision history:

Date	REV.	Description	Page
2023.1.1	1.0	Original	